2.5 V/3.3 V 2:1:15 Differential ECL/PECL ÷1/÷2 Clock Driver

The NB100LVEP222 is a low skew 2:1:15 differential $\div 1/\div 2$ ECL fanout buffer designed with clock distribution in mind. The LVECL/LVPECL input signal pairs can be used in a differential configuration or single–ended (with V_{BB} output reference bypassed and connected to the unused input of a pair). Either of two fully differential clock inputs may be selected. Each of the four output banks of 2, 3, 4, and 6 differential pairs may be independently configured to fanout 1X or 1/2X of the input frequency. When the output banks are configured with the $\div 1$ mode, data can also be distributed. The LVEP222 specifically guarantees low output to output skew. Optimal design, layout, and processing minimize skew within a device and from lot to lot. This device is an improved version of the MC100LVE222 with higher speed capability and reduced skew.

The fsel pins and CLK_Sel pin are asynchronous control inputs. Any changes may cause indeterminate output states requiring an MR pulse to resynchronize any 1/2X outputs (See Figure 4). Unused output pairs should be left unterminated (open) to reduce power and switching noise.

The NB100LVEP222, as with most ECL devices, can be operated from a positive $V_{\rm CC}/V_{\rm CC0}$ supply in LVPECL mode. This allows the LVEP222 to be used for high performance clock distribution in +2.5/3.3 V systems. In a PECL environment series or Thevenin line, terminations are typically used as they require no additional power supplies. For more information on using PECL, designers should refer to Application Note AN1406/D. For a SPICE model, refer to Application Note AN1560/D.

The V_{BB} pin, an internally generated voltage supply, is available to this device only. For single–ended LVPECL input conditions, the unused differential input is connected to V_{BB} as a switching reference voltage. V_{BB} may also rebias AC coupled inputs. When used, decouple V_{BB} and V_{CC}/V_{CC0} via a 0.01 μF capacitor and limit current sourcing or sinking to 0.5 mA. When not used, V_{BB} should be left open. Single–ended CLK input operation is limited to a $V_{CC}/V_{CC0} \geq 3.0~V$ in LVPECL mode, or $V_{EE} \leq -3.0~V$ in NECL mode.

Features

- 20 ps Output-to-Output Skew
- 85 ps Part-to-Part Skew
- Selectable 1x or 1/2x Frequency Outputs
- LVPECL Mode Operating Range: V_{CC}/V_{CC0} = 2.375 V to 3.8 V with V_{EE} = 0 V
- NECL Mode Operating Range:
 V_{CC}/V_{CC0} = 0 V with V_{EE} = −2.375 V to −3.8 V
- Internal Input Pulldown Resistors
- Performance Upgrade to ON Semiconductor's MC100LVE222
- V_{BB} Output
- These Devices are Pb-Free and are RoHS Compliant

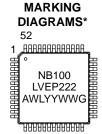


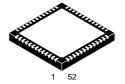
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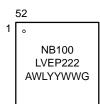


LQFP-52 FA SUFFIX CASE 848H





QFN-52 MN SUFFIX CASE 485M



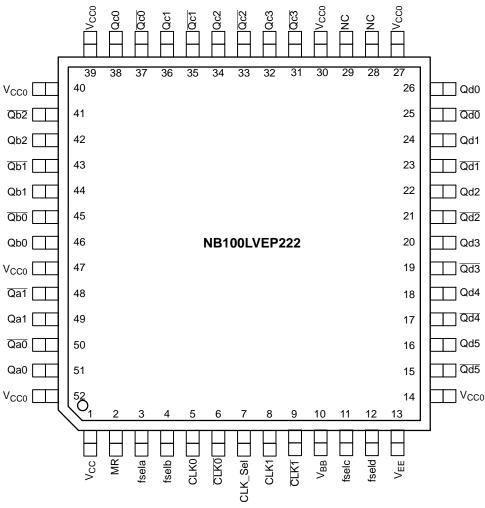
A = Assembly Location

WL = Wafer Lot YY = Year WW = Work Week G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 11 of this data sheet.

^{*}For additional marking information, refer to Application Note AND8002/D.



All V_{CC} , V_{CC0} , and V_{EE} pins must be externally connected to appropriate Power Supply to guarantee proper operation. V_{CC} pin internally connected to V_{CC0} pins. The thermally conductive exposed pad on package bottom (see package case drawing) must be attached to a heat–sinking conduit. This exposed pad is electrically connected to V_{EE} internally.

Figure 1. 52-Lead LQFP Pinout (Top View)

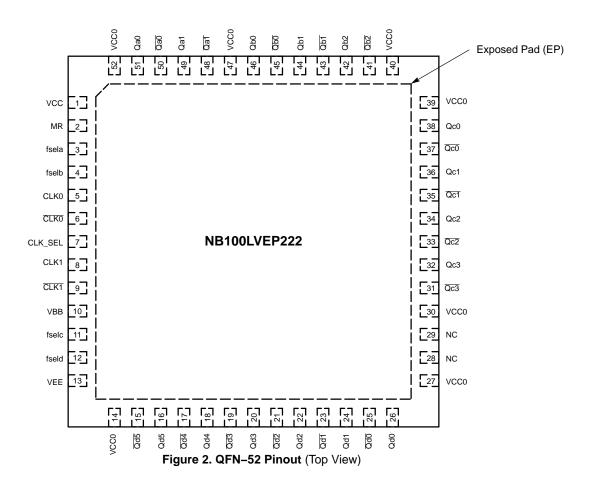


Table 1. PIN DESCRIPTION

PIN	FUNCTION
CLK0*, <u>CLK0</u> **	ECL Differential Input Clock
CLK1*, CLK1**	ECL Differential Input Clock
CLK_Sel*	ECL Clock Select
MR*	ECL Master Reset
Qa0:1, Qa0:1	ECL Differential Outputs
Qb0:2, Qb0:2	ECL Differential Outputs
Qc0:3, Qc0:3	ECL Differential Outputs
Qd0:5, Qd0:5	ECL Differential Outputs
fseln*	ECL ÷1 or ÷2 Select
V_{BB}	Reference Voltage Output
V _{CC} , V _{CC0}	Positive Supply, $V_{CC} = V_{CC0}$
V _{EE} ***	Negative Supply
NC	No Connect

* Pins will default LOW when left open.

Table 2. FUNCTION TABLE

.a.a.a z aa.a.a.a.a.a.a.a.a.a.a.a.a								
	Function							
Input	L	Н						
MR CLK_Sel	Active CLK0	Reset CLK1						
fseln	÷1	÷2						

^{**} Pins will default HIGH when left open.

 $^{^{\}star\star\star}$ The thermally conductive exposed pad on the bottom of the package is electrically connected to V_{EE} internally.

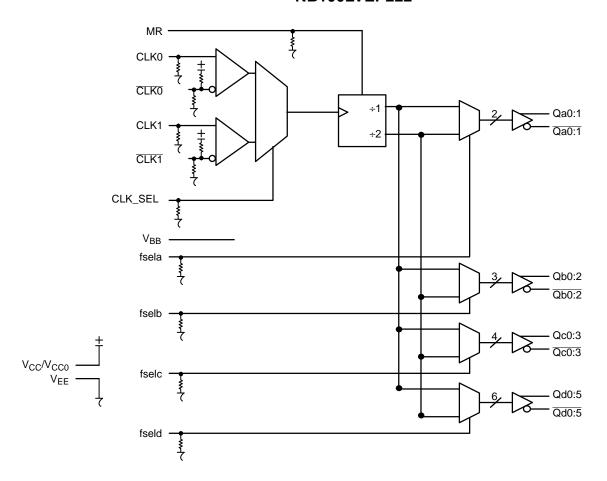


Figure 3. Logic Diagram

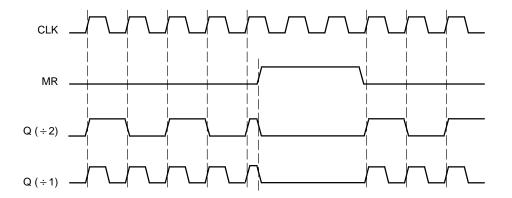


Figure 4. Master Reset (MR) Timing Diagram

Table 3. ATTRIBUTES

Characteristic	V	alue		
Internal Input Pulldown Resistor		75 kΩ		
Internal Input Pullup Resistor		37	'.5 kΩ	
ESD Protection	>	2 kV 200 V 2 kV		
Moisture Sensitivity, Indefinite Time Ou	t of Drypack (Note 1)	Pb Pkg	Pb-Free Pkg	
	LQFP-52 QFN-52	Level 2 -	Level 3 Level 2	
Flammability Rating	UL 94 V-	O @ 0.125 in		
Transistor Count	821	Devices		
Meets or Exceeds JEDEC Spec EIA/JE	SD78 IC Latchup Test			

^{1.} For additional information, refer to Application Note AND8003/D.

Table 4. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V _{CC} /V _{CC0}	PECL Mode Power Supply	V _{EE} = 0 V		6	V
V _{EE}	NECL Mode Power Supply	$V_{CC}/V_{CC0} = 0 V$		-6	V
VI	PECL Mode Input Voltage NECL Mode Input Voltage	$V_{EE} = 0 V$ $V_{CC}/V_{CC0} = 0 V$	$\begin{array}{c} V_I \leq V_{CC}/V_{CC0} \\ V_I \geq V_{EE} \end{array}$	6 to 0 –6 to 0	V V
l _{out}	Output Current	Continuous Surge		50 100	mA mA
I _{BB}	V _{BB} Sink/Source			±0.5	mA
T _A	Operating Temperature Range			-40 to +85	°C
T _{stg}	Storage Temperature Range			-65 to +150	°C
θ_{JA}	Thermal Resistance (Junction-to-Ambient) (See Application Information)	0 lfpm 500 lfpm	LQFP-52 LQFP-52	35.6 30	°C/W
$\theta_{\sf JC}$	Thermal Resistance (Junction-to-Case) (See Application Information)	0 lfpm 500 lfpm	LQFP-52 LQFP-52	3.2 6.4	°C/W
θ_{JA}	Thermal Resistance (Junction-to-Ambient) (Note)	0 lfpm 500 lfpm	QFN-52 QFN-52	25 19.6	°C/W
θ JC	Thermal Resistance (Junction–to–Case) (Note)	2S2P	QFN-52	21	°C/W
T _{sol}	Wave Solder	< 2 to 3 sec @ 248°C		265	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 5. LVPECL DC CHARACTERISTICS V_{CC} = V_{CC0} = 2.5 V; V_{EE} = 0 V (Note 2)

			-40°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I _{EE}	Power Supply Current	100	125	150	104	130	156	112	140	168	mA
V _{OH}	Output HIGH Voltage (Note 3)	1355	1480	1605	1355	1480	1605	1355	1480	1605	mV
V _{OL}	Output LOW Voltage (Note 3)	555	680	900	555	680	900	555	680	900	mV
V _{IH}	Input HIGH Voltage (Single–Ended) (Note 4)	1335		1620	1335		1620	1275		1620	mV
V _{IL}	Input LOW Voltage (Single–Ended) (Note 4)	555		900	555		900	555		900	mV
V _{IHCMR}	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 5) (Figure 6)	1.2		2.5	1.2		2.5	1.2		2.5	V
I _{IH}	Input HIGH Current			150			150			150	μΑ
I _{IL}	Input LOW Current CLK	0.5 -150			0.5 -150			0.5 -150			μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

- 2. Input and output parameters vary 1:1 with V_{CC}/V_{CC0} . V_{EE} can vary + 0.125 V to -1.3 V.

- All loading with 50 Ω to V_{CC}/V_{CC0} 2.0 V.
 Do not use V_{BB} Pin #10 at V_{CC}/V_{CC0} < 3.0 V (see AND8066).
 V_{IHCMR} min varies 1:1 with V_{EE}, V_{IHCMR} max varies 1:1 with V_{CC}/V_{CC0}. The V_{IHCMR} range is referenced to the most positive side of the differential input signal.

Table 6. LVPECL DC CHARACTERISTICS V_{CC} = V_{CC0} = 3.3 V; V_{EE} = 0.0 V (Note 6)

			-40°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I _{EE}	Power Supply Current	100	125	150	104	130	156	112	140	168	mA
V _{OH}	Output HIGH Voltage (Note 7)	2155	2280	2405	2155	2280	2405	2155	2280	2405	mV
V _{OL}	Output LOW Voltage (Note 7)	1355	1480	1700	1355	1480	1700	1355	1480	1700	mV
V _{IH}	Input HIGH Voltage (Single-Ended)	2135		2420	2135		2420	2135		2420	mV
V _{IL}	Input LOW Voltage (Single–Ended)	1355		1700	1355		1700	1355		1700	mV
V _{BB}	Output Reference Voltage (Note 8)	1775	1875	1975	1775	1875	1975	1775	1875	1975	mV
V _{IHCMR}	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 9) (Figure 6)	1.2		3.3	1.2		3.3	1.2		3.3	V
I _{IH}	Input HIGH Current			150			150			150	μΑ
I _{IL}	Input LOW Current CLK CLK	0.5 -150			0.5 -150			0.5 -150			μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

- Input and output parameters vary 1:1 with V_{CC}/V_{CC0}. V_{EE} can vary + 0.925 V to −0.5 V.
 All loading with 50 Ω to V_{CC}/V_{CC0}−2.0 V.
 Single–Ended input operation is limited V_{CC}/V_{CC0} ≥ 3.0 V in LVPECL mode.
 V_{IHCMR} min varies 1:1 with V_{EE}, V_{IHCMR} max varies 1:1 with V_{CC}/V_{CC0}. The V_{IHCMR} range is referenced to the most positive side of the differential input signal.

Table 7. LVNECL DC CHARACTERISTICS $V_{CC} = V_{CC0} = 0.0 \text{ V}$; $V_{EE} = -3.8 \text{ V}$ to -2.375 V (Note 10)

		-40°C				25°C					
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I _{EE}	Power Supply Current	100	125	150	104	130	156	112	140	168	mA
V _{OH}	Output HIGH Voltage (Note 11)	-1145	-1020	-895	-1145	-1020	-895	-1145	-1020	-895	mV
V _{OL}	Output LOW Voltage (Note 11)	-1945	-1820	-1600	-1945	-1820	-1600	-1945	-1820	-1600	mV
V _{IH}	Input HIGH Voltage (Single-Ended)	-1165		-880	-1165		-880	-1165		-880	mV
V _{IL}	Input LOW Voltage (Single-Ended)	-1945		-1600	-1945		-1600	-1945		-1600	mV
V_{BB}	Output Reference Voltage (Note 12)	-1525	-1425	-1325	-1525	-1425	-1325	-1525	-1425	-1325	mV
V _{IHCMR}	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 13) (Figure 6)	V _{EE}	+ 1.2	0.0	V _{EE}	+ 1.2	0.0	V _{EE}	+ 1.2	0.0	V
I _{IH}	Input HIGH Current			150			150			150	μΑ
I _{IL}	Input LOW Current CLK CLK	0.5 -150			0.5 -150			0.5 -150			μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

^{10.} Input and output parameters vary 1:1 with V_{CC}/V_{CC0}.
11. All loading with 50 Ω to V_{CC}/V_{CC0} − 2.0 V.
12. Single–Ended input operation is limited V_{EE} ≤ −3.0 V in NECL mode.
13. V_{IHCMR} min varies 1:1 with V_{EE}, V_{IHCMR} max varies 1:1 with V_{CC}/V_{CC0}. The V_{IHCMR} range is referenced to the most positive side of the differential input signal.

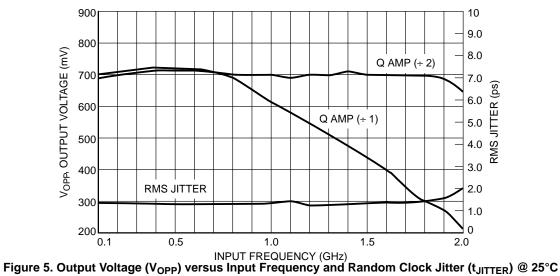
Table 8. AC CHARACTERISTICS $V_{CC} = V_{CC0} = 2.375$ to 3.8 V; $V_{EE} = 0.0$ V or $V_{CC} = V_{CC0} = 0.0$ V; $V_{EE} = -2.375$ to -3.8 V (Note 14)

			-40°C		25°C			85°C			
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
V _{Opp}	$\begin{array}{ll} \text{Differential Output Voltage} \\ \text{(Figure 5)} & f_{\text{out}} = 50 \text{ MHz} \\ f_{\text{out}} = 0.8 \text{ GHz} \\ f_{\text{out}} = 1.0 \text{ GHz} \end{array}$	500 550 500	600 650 650		500 525 425	600 650 650		500 500 400	600 650 600		mV
t _{PLH} t _{PHL}	Propagation Delay (Differential Configuration) $ \begin{array}{c} \text{CLKx-Q}_X\\ \text{MR-Q}_{XX} \end{array}$	650 700	800 900	900 1200	700 700	875 900	1000 1200	850 700	975 900	1150 1200	ps
t _{skew}	Within-Device Skew (Note 15) (÷1 Mode) - Qa[0:1] - Qb[0:2] - Qc[0:3] - Qd[0:5]		10 10 20 10	40 40 60 40		10 10 20 10	40 40 60 40		10 10 20 10	40 40 60 40	ps
	– Qa _N , Qb _N , Qd _N – All Outputs		20	60		20	60		20	60	
t _{skew}	Within-Device Skew (Note 15) (÷2 Mode) - Qa[0:1] - Qb[0:2] - Qc[0:3] - Qd[0:5]		15 15 20 15	70 70 70 70		10 10 20 10	40 40 50 40		15 10 15 15	70 40 70 70	ps
	– Qa _N , Qb _N , Qd _N – All Outputs		15 20	70 70		10 20	40 50		15 15	70 70	
t _{skew}	Device-to-Device Skew (Differential Configuration) (Note 16)		85	300		85	300		85	300	ps
t _{JITTER}	Random Clock Jitter (Figure 5) (RMS)		1	5		1	4		1	5	ps
V _{PP}	Input Swing (Differential Configuration) (Note 17) (Figure 6)		800	1200	150	800	1200	150	800	1200	mV
DCO	Output Duty Cycle	49.5	50	50.5	49.5	50	50.5	49.5	50	50.5	%
t _r /t _f	Output Rise/Fall Time 20%-80%	100	200	300	100	200	300	150	250	350	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

^{16.} Device–to–Device skew for identical transitions at identical V_{CC}/V_{CC0} levels.

17. V_{PP} is the differential configuration input voltage swing required to maintain AC characteristics including t_{PD} and device–to–device skew.



^{14.} Measured with LVPECL 750 mV source, 50% duty cycle clock source. All outputs loaded with 50 Ω to V_{CC}/V_{CC0} – 2.0 V.

^{15.} Skew is measured between outputs under identical transitions and operating conditions.

Figure 6. LVPECL Differential Input Levels

APPLICATIONS INFORMATION

Using the thermally enhanced package of the NB100LVEP222

The NB100LVEP222 uses a thermally enhanced 52-lead LQFP package. The package is molded so that a portion of the leadframe is exposed at the surface of the package bottom side. This exposed metal pad will provide the low thermal impedance that supports the power consumption of the NB100LVEP222 high-speed bipolar integrated circuit and will ease the power management task for the system design. In multilayer board designs, a thermal land pattern on the printed circuit board and thermal vias are recommended to maximize both the removal of heat from the package and electrical performance of the NB100LVEP222. The size of the land pattern can be larger, smaller, or even take on a different shape than the exposed pad on the package. However, the solderable area should be at least the same size and shape as the exposed pad on the package. Direct soldering of the exposed pad to the thermal land will provide an efficient thermal conduit. The thermal vias will connect the exposed pad of the package to internal copper planes of the board. The number of vias, spacing, via diameters and land pattern design depend on the application and the amount of heat to be removed from the package.

Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern.

The recommended thermal land design for NB100LVEP222 applications on multi-layer boards comprises a 4 X 4 thermal via array using a 1.2 mm pitch as shown in Figure 7 providing an efficient heat removal path.

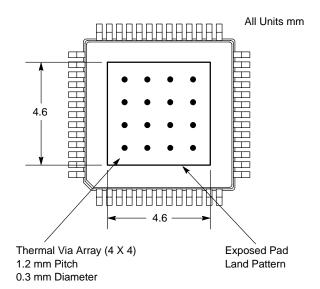


Figure 7. Recommended Thermal Land Pattern

The via diameter should be approximately 0.3 mm with 1 oz. copper via barrel plating. Solder wicking inside the via may result in voiding during the solder process and must be avoided. If the copper plating does not plug the vias, stencil print solder paste onto the printed circuit pad. This will supply enough solder paste to fill those vias and not starve

the solder joints. The attachment process for the exposed pad package is equivalent to standard surface mount packages. Figure 8, "Recommended solder mask openings", shows a recommended solder mask opening with respect to a 4 X 4 thermal via array. Because a large solder mask opening may result in a poor rework release, the opening should be subdivided as shown in Figure 8. For the nominal package standoff of 0.1 mm, a stencil thickness of 5 to 8 mils should be considered.

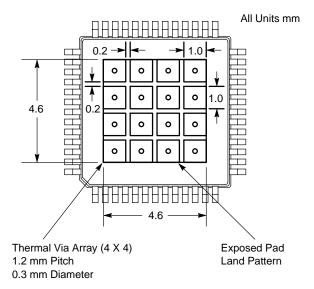


Figure 8. Recommended Solder Mask Openings

Proper thermal management is critical for reliable system operation. This is especially true for high–fanout and high output drive capability products.

For thermal system analysis and junction temperature calculation the thermal resistance parameters of the package is provided:

Table 9. Thermal Resistance *

lfpm	θJA °C/W	θJC °C/W
0	35.6	3.2
100	32.8	4.9
500	30.0	6.4

^{*} Junction to ambient and Junction to board, four-conductor layer test board (2S2P) per JESD 51-8

These recommendations are to be used as a guideline, only. It is therefore recommended that users employ sufficient thermal modeling analysis to assist in applying the general recommendations to their particular application to assure adequate thermal performance. The exposed pad of the NB100LVEP222 package <u>is</u> electrically shorted to the substrate of the integrated circuit and V_{EE} . The thermal land should be electrically connected to V_{EE} .

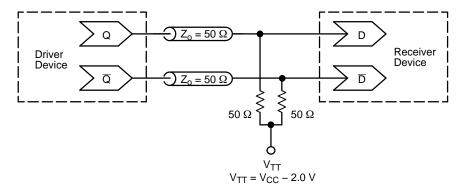


Figure 9. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D – Termination of ECL Logic Devices.)

Resource Reference of Application Notes

AN1405/D - ECL Clock Distribution Techniques

AN1406/D - Designing with PECL (ECL at +5.0 V)

AN1503/D - ECLinPS™ I/O SPiCE Modeling Kit

AN1504/D - Metastability and the ECLinPS Family

AN1568/D - Interfacing Between LVDS and ECL

AN1642/D - The ECL Translator Guide

AND8001/D - Odd Number Counters Design

AND8002/D - Marking and Date Codes

AND8020/D - Termination of ECL Logic Devices

AND8066/D - Interfacing with ECLinPS

AND8090/D - AC Characteristics of ECL Devices

ORDERING INFORMATION

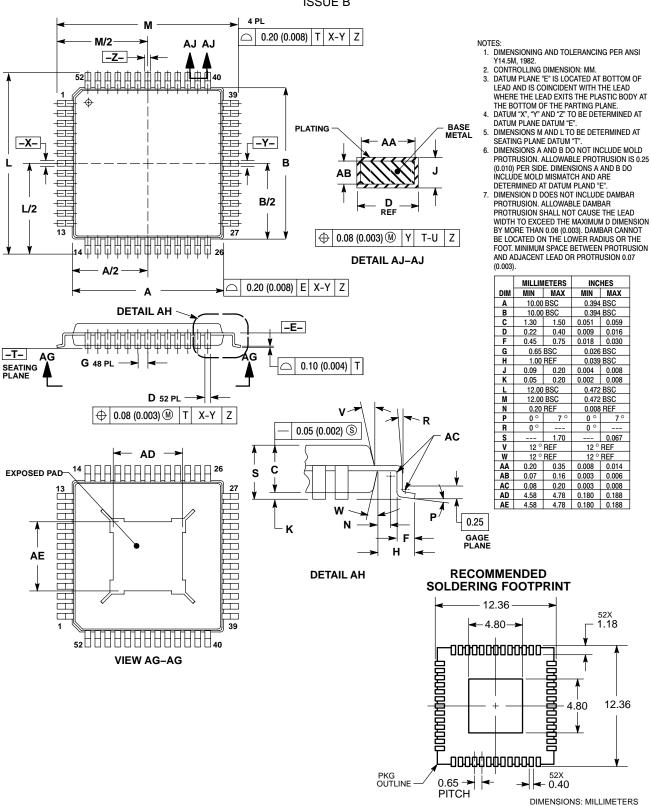
Device	Package	Shipping [†]			
NB100LVEP222FAG	LQFP-52 (Pb-Free)	160 Units / Tray			
NB100LVEP222FARG	B100LVEP222FARG				
NB100LVEP222MNG	QFN-52 (Pb-Free)	260 Units / Tray			
NB100LVEP222MNR2G	QFN-52 (Pb-Free)	2000 / Tape & Reel			

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

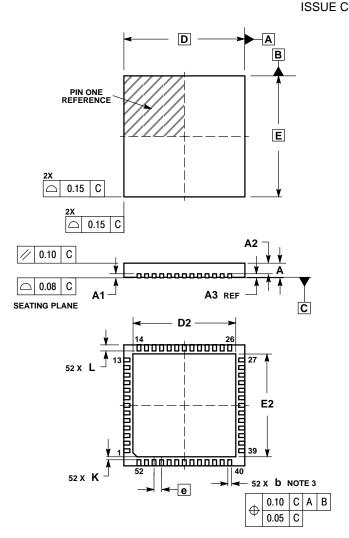
LQFP 52 LEAD EXPOSED PAD

CASE 848H ISSUE B



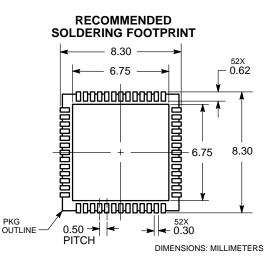
PACKAGE DIMENSIONS

52 PIN QFN 8x8, 0.5P CASE 485M



- DIMENSIONING AND TOLERANCING PER
- DIMENSIONING AND TOLERANGING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS							
DIM	MIN	MAX						
Α	0.80	1.00						
A1	0.00	0.05						
A2	0.60	0.80						
A3	0.20	REF						
b	0.18	0.30						
D	8.00	BSC						
D2	6.50	6.80						
Е	8.00	BSC						
E2	6.50	6.80						
е	0.50	BSC						
K	0.20							
L	0.30	0.50						



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